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| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>10532253 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>STAMP, KEVIN |
|  | <b>Examiner</b><br><br>JENNER YEHL             | <b>Art Unit</b><br><br>4118  |

| SEARCHED |  |            |          |
|----------|--|------------|----------|
| Class    | Subclass                                       | Date       | Examiner |
| 604      | 68   | 11/17/2008 | JY       |
|          | 18   | 11/18/2008 | JY       |
|          | 187, 15, 16, 18, 72                            | 11/19/2008 | JY       |
|          | 63, 6.11, 6.12, 36, 63, 70, 118, 124, 137, 134 | 11/20/2008 | JY       |
|          | 240, 500, 131                                  | 11/25/2008 | JY       |
|          | 533, 538                                       | 11/26/2008 | JY       |
|          | 432  | 12/2/2008  | JY       |

| SEARCH NOTES   |            |          |
|--|------------|----------|
| Search Notes   | Date       | Examiner |
| Inventor search and IDS search                                     | 11/13/2008 | JY       |
| Spoke with Chris Koharski about potential allowable subject matter | 11/25/2008 | JY       |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |

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